

Preliminary

T-75-49



Am79865/Am79866

Advanced
Micro
Devices

Physical Data Transmitter/Physical Data Receiver

DISTINCTIVE CHARACTERISTICS

- Parallel input to the PDT is a 5-bit encoded NRZ symbol clocked by LSCLK
- Parallel output from the PDR is a 5-bit unframed NRZ symbol clocked by RSCLK
- The on-chip Phase-Locked-Loop (PLL) only requires an external frequency reference
- 125 MBaud (100 Mbps) serial link data rate
- PECL serial I/Os connect to most Fiber Optic Transmitters and Receivers directly with proper termination
- Dedicated pins provide electrical loopback data path
- 20-pin Plastic Leaded Chip Carrier (PLCC)
- Single +5 V power supply operation

GENERAL DESCRIPTION

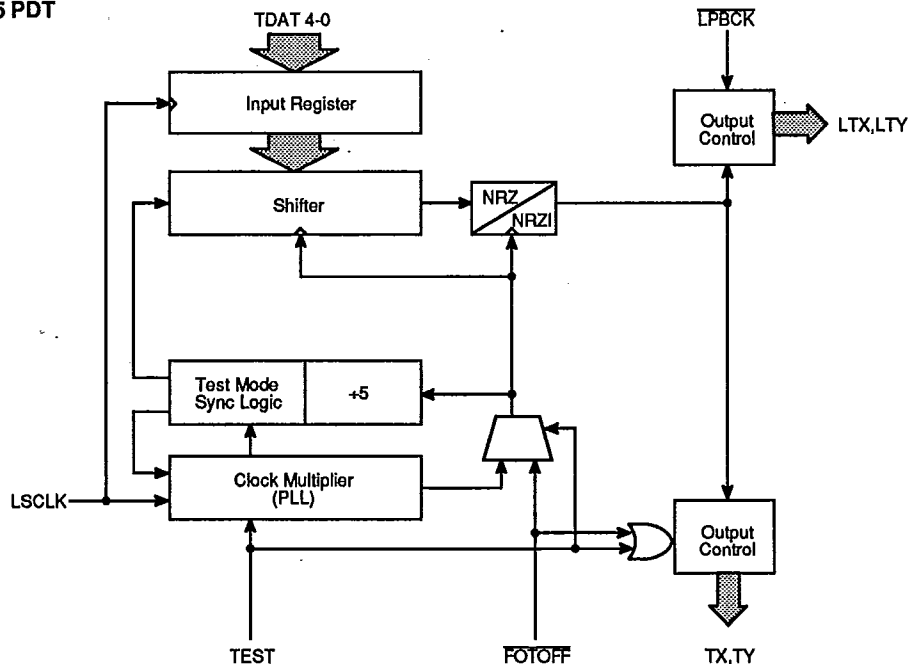
The SUPERNET® 2 FDDI Physical Layer Protocol (PHY) chip set includes the Physical Layer Controller (PLC), the Physical Data Transmitter (PDT) and the Physical Data Receiver (PDR). The PLC, PDT and PDR are collectively known as the AmPHY. The PLC performs FDDI physical layer functions which includes, among others, the 4B5B encoding and decoding.

The PDT converts encoded symbols into a serial NRZI data stream. The on-chip PLL generates a bit rate clock from the LSCLK reference.

The PDR uses a built-in clock recovery PLL to extract clock information from the received data stream. The recovered clock is used for serial-to-parallel data conversion.

BLOCK DIAGRAM

Am79865 PDT



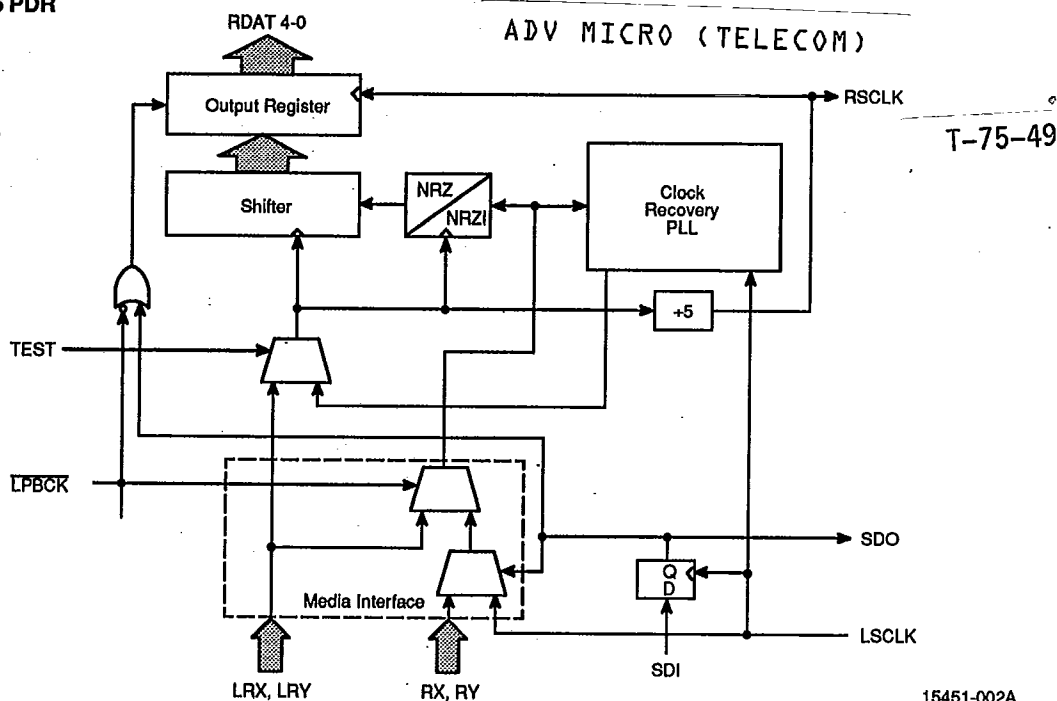
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BLOCK DIAGRAM

Am79866 PDR

48E D 0257527 0030993 2 AMD3

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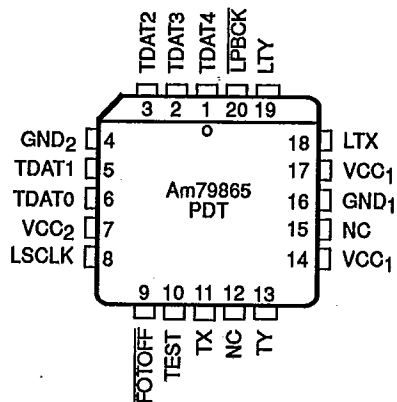


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CONNECTION DIAGRAMS

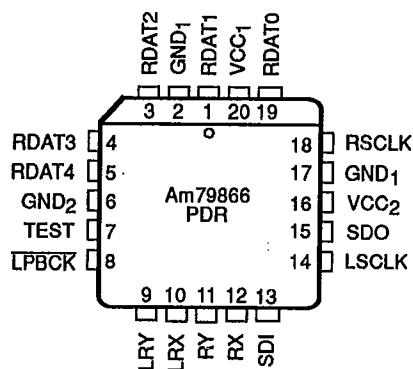
Top View

20-Pin PLCC



15451-003A

20-Pin PLCC



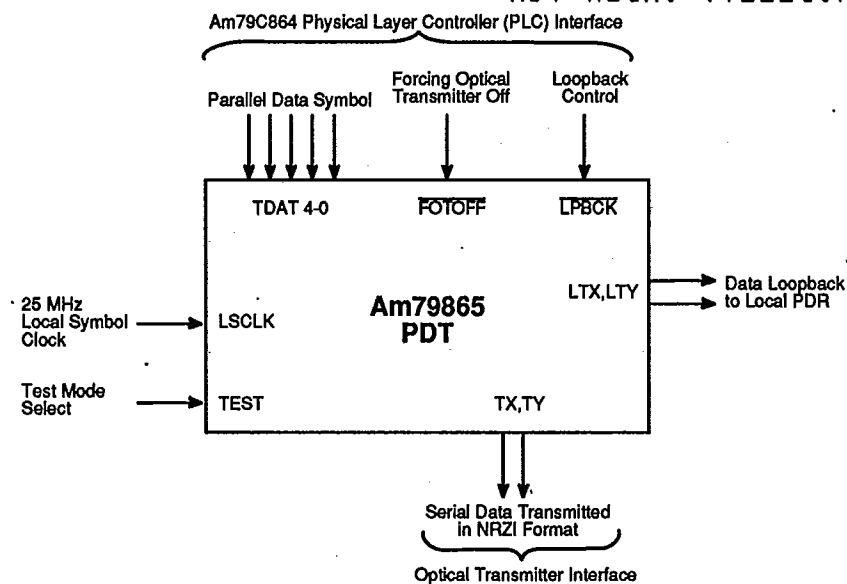
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LOGIC SYMBOLS

48E D 0257527 0030994 4 AMD3

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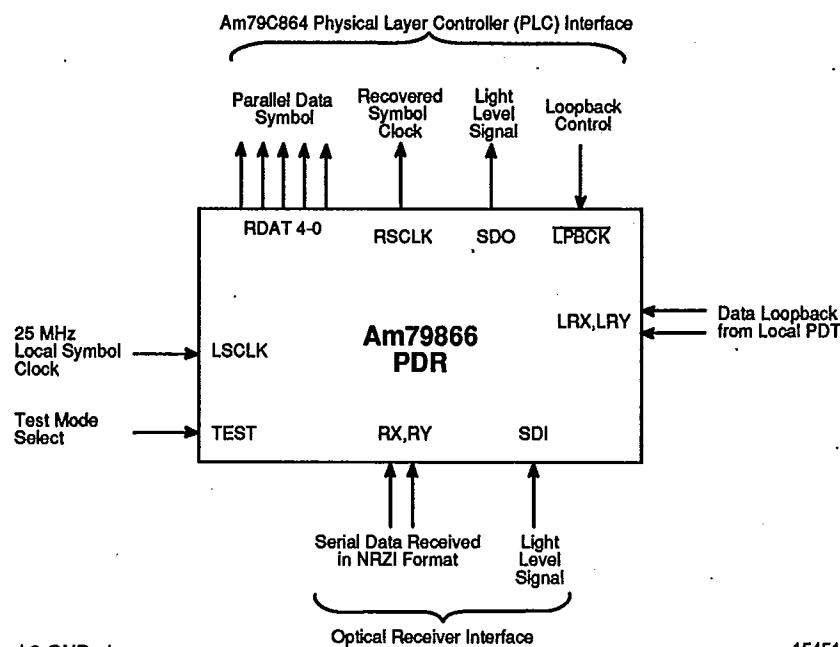
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Note:

1. 3 Vcc pins and 2 GND pins.

15451-005A



Note:

1. 2 Vcc pins and 3 GND pins.

15451-006A

ORDERING INFORMATION

48E D 0257527 0030995 6 AMD3

Standard Products

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AMD standard products are available in several packages and operating ranges. The order number (Valid Combination) is formed by a combination of:

Device Number
Speed Option (if applicable)
Package Type
Temperature Range
Optional Processing

T-75-49

AM79865

J

C

OPTIONAL PROCESSING

Blank = Standard processing

TEMPERATURE RANGE

C = Commercial (0 to +70°C)

PACKAGE TYPE

J = 20-pin Plastic Leaded Chip Carrier (PL 020)

SPEED OPTION

Not Applicable

DEVICE NUMBER/DESCRIPTION

Am79865 = Physical Data Transmitter

Am79866 = Physical Data Receiver

Valid Combinations	
AM79865	JC
AM79866	JC

Valid Combinations

Valid Combinations list configurations planned to be supported in volume for this device. Consult the local AMD sales office to confirm availability of specific valid combinations, and to check on newly released valid combinations.

Am79865 PDT PIN DESCRIPTION**TDAT 4-0****Transmit Data (TTL Inputs)**

These five inputs accept data symbols from the Am79C864 PLC, latched by the rising edge of LSCLK.

LSCLK**Local Symbol Clock (TTL Input)**

This pin supplies the frequency and phase reference to the internal PLL clock multiplier. It should be driven by an external 25 MHz crystal-controlled clock source.

FOTOFF**Fiber Optic Transmitter Off (TTL Input, active LOW)**

When held LOW, the TX output is forced LOW and TY output is forced HIGH so that the Fiber Optic Transmitter will output logical 0. In test mode, FOTOFF is used as the test clock input and does not control TX/TY.

LPBCK**Loopback Control (TTL Input, active LOW)**

When asserted, the LTX/LTY outputs transmit the NRZI serial bit stream to the PDR to establish the loopback data path. When deasserted, the LTX output is forced LOW and LTY output is forced HIGH.

TEST**Test Mode Enable (TTL Input)**

When asserted, the PDT is in Test mode. For normal operation, TEST pin must be tied LOW.

TX, TY****Transmit Data (PECL Differential Outputs)**

These transmit outputs carry differential NRZI data. They can be forced to logical 0 (TX LOW, TY HIGH) by asserting the FOTOFF input.

LTX, LTY****Loopback Transmit Data (PECL Differential Outputs)**

These differential outputs carry the same signal as TX/TY when the LPBCK input is asserted (LOW). LTX/LTY should be connected to the LRX/LRY pins of Am79866 PDR to perform loopback function. When LPBCK is deasserted (HIGH), LTX is forced LOW and LTY is forced HIGH.

V_{CC1}, V_{CC2}**Power Supply**

V_{CC1}, V_{CC2} are +5.0V nominal power supply pins. V_{CC1} powers all TTL and ECL I/O circuits. V_{CC2} powers all internal logic gates and analog circuits. They must be connected to a common external supply.

GND₁, GND₂**Ground Pins**

GND₁ is TTL and ECL I/O ground. GND₂ is the internal logic and analog ground. They must be connected to a common external ground reference.

**All differential PECL outputs carry data at ECL voltage levels referenced to +5.0 V (PECL levels). The external terminations required are shown in the Interface Connection Diagram in the Appendix.

Am79866 PDR PIN DESCRIPTION**LSCLK****Local Symbol Clock (TTL Input)**

LSCLK is driven by an external frequency source at the 25 MHz symbol rate. This signal is used as a frequency reference for the PDR clock-recovery PLL.

LPBCK**Loopback (TTL Input, active LOW)**

When active, LPBCK selects the serial data stream at LRX/LRY inputs as the received data. When HIGH, RX/RX are selected. This function is used during system loopback test to bypass the transmission medium.

TEST**TEST Mode Enable (TTL Input)**

When asserted, the PDR is in Test mode. For normal operation, TEST pin must be tied LOW.

RDAT 4-0**Received Data (TTL Outputs)**

These 5-bit parallel outputs are clocked by the falling edge of RSCLK and carry the NRZ data symbols to the PLC.

RSCLK**Recovered Symbol Clock (TTL Output)**

RSCLK is derived from the clock synchronization PLL circuit. It is synchronous to the received serial data, and is the recovered bit clock divided-by-five. This is a 25 MHz clock.

SDI**Signal Detect Input (PECL Single-ended Input)**

SDI typically comes from the fiber optic receiver to indicate that the received optical signal is above the detection threshold. When asserted (HIGH), the data on RX/

RY are used for the input to the PDR. When deasserted (LOW), the RX/RX data stream is gated off and the PLL locks onto the LSCLK.

SDO**Signal Detect Output (TTL Output)**

SDO is the SDI input synchronized by LSCLK. It has the same logical sense as SDI, i.e., HIGH indicates the received optical signal is above the detection threshold.

RX,RY***Received Data (PECL Differential Line Receiver Inputs)**

These pins receive NRZI data.

LRX,LRY***Loopback Received Data (PECL Differential Line Receiver Inputs)**

This input pair should be connected to the PDT LTX/LTY outputs through properly terminated lines to establish the loopback data path. When LPBCK is asserted, LRX/LRY carry the data to be used as the input to the PDR. In Test mode, LRX/LRY become the test clock input.

Vcc1,Vcc2**Power Supply**

Vcc1,Vcc2 are +5.0 V nominal power supply pins. Vcc1 powers all TTL and ECL I/O circuits. Vcc2 powers all internal logic gates and analog circuits. They must be connected to a common external supply.

GND1,GND2**Ground Pins**

GND1 is TTL and ECL I/O ground. GND2 is the internal logic and analog ground. They must be connected to a common external ground reference.

*RX/RX and LRX/LRY are differential line receivers which have high input sensitivity and wide common-mode range. They can also accept PECL voltage swings and shall be driven by properly terminated transmission lines.

FUNCTIONAL DESCRIPTION**Normal Operation Mode**

The Am79865 PDT accepts encoded data symbols at TDAT 4-0 pins. The 5-bit symbol is latched into the PDT by the rising edge of LSCLK, serialized, converted to NRZI format and shifted to the outputs (TDAT4 bit is transmitted first). There are two pairs of serial data outputs capable of driving either Fiber Optic Interface hardware or wire transmission lines without external buffering. The TX/TY pair is connected to the serial link and the LTX/LTY pair is used in the loopback connection to the Am79866 PDR.

The PDT uses LSCLK as the frequency reference to generate the serial link data rate. The external clock source must be crystal controlled and continuous. All of the internal logic of PDT runs on an internal clock that is PLL-multiplied from the external reference source. The PDT's internal PLL is referenced to the rising edges of LSCLK only.

The input clock frequency required to achieve 125 MBaud on the serial link is 25 MHz at LSCLK. In order to generate the serial output waveforms conforming to the FDDI specification, the external reference clock (LSCLK) must meet FDDI frequency and stability requirements. The PDT serial output typically contains less than 0.4 ns peak-to-peak jitter at 125 MBaud. The latency from the LSCLK to the serial output is typically 4 to 6 bits (8 ns/bit).

The Am79866 PDR accepts encoded NRZI serial data on the RX/RX inputs and converts them to NRZ format. It then latches the unframed symbol (5 bits) to the RDAT 4-0 outputs on the falling edge of RSCLK.

The heart of the Am79866 PDR chip is its clock-recovery PLL which extracts encoded clock information from the serial NRZI data stream and recovers the data. The PLL examines every data transition in the received serial stream and aligns its internal bit clock with these data transitions. In order to guarantee the correct operation of the PLL, the encoding scheme (such as the FDDI 4B5B code) must insure adequate transition density of the encoded data stream.

The PDR has input jitter tolerance characteristics that meet or exceed the recommendations of Physical Layer Medium Dependent (PMD) FDDI document. Typically, at 125 MBaud (8 ns/bit), the peak-to-peak Duty-Cycle Distortion (DCD) tolerance is 1.4 ns, the peak-to-peak Data-Dependent Jitter (DDJ) tolerance is 2.2 ns, and the peak-to-peak Random Jitter (RJ) tolerance is 2.27 ns. The total combined peak-to-peak jitter tolerance is typically 5 ns with bit error rate (BER) less than 2.5×10^{-10} .

The PDR's PLL typically has an acquisition time of 100 μ s or less when 'Master' symbols (one data transition within ten bits) are received. The acquisition time reduces with increasing transition density in the data stream.

The SDI input qualifies the data at RX/RX. When SDI is LOW, the PDR uses LSCLK as the PLL input and forces LOW at the Output Register. The LPBCK input selects the data source between RX/RX and LRX/LRY. When LPBCK is LOW, the SDI input is ignored.

When SDI is HIGH and the RX/RX input stream contains no data transition for PLL input, the PLL operating frequency range is limited by the LSCLK reference. The observed RSCLK output frequency is generally within 0.5 % of the LSCLK frequency.

Under normal conditions, the frequency of LSCLK multiplied by five must be within 0.25 % of the expected received data for the PLL to operate correctly. (Note, FDDI specifies the two frequencies to be within 50 ppm or 0.005 % of each other.)

Am79865 PDT Functional Block Description**Clock Multiplier**

LSCLK supplies the reference frequency which is multiplied by five using an on-chip PLL. The transmission rate and all serialization logic are controlled by the internally generated bit clock.

Input Register

TDAT 4-0 are clocked into the Input Register by the rising edge of LSCLK.

Shifter

Parallel data are loaded from the Input Register into the Shifter at the internally generated symbol boundary, and serially shifted at the bit clock rate.

NRZ-to-NRZI Converter

The NRZ output of the Shifter is converted into NRZI data patterns for transmission.

Output Control

The differential outputs carry the encoded serial NRZI bit stream. The TX/TY pair can be forced to logical 0 (TX LOW, TY HIGH) by asserting FOTOFF input. The LTX/LTY pair can be forced to logical 0 (LTX LOW, LTY HIGH) by deasserting the LPBCK input.

Am79866 PDR Functional Block Description**Clock-Recovery PLL**

The clock-recovery PLL separates the input data stream into clock and data patterns. The PLL operating frequency is established by the reference at LSCLK. The PLL is capable of tracking data correctly within ± 0.25 %

of LSCLK (exceeds the frequency range defined by the FDDI specification).

Media Interface

The RX/RX inputs are typically driven by differential PECL voltages, referenced to +5 V. These inputs accept the encoded NRZI serial data. LRX/LRY are also differential line receiver inputs which accept the loopback data stream from the local PDT LTX/LTY outputs.

NRZI-TO-NRZ Converter

Serial data are retimed and associated jitter is removed. Retimed data are converted into NRZ format prior to the Shifter input.

Shifter

The Shifter is serially loaded from the NRZI_TO_NRZ converter, using the recovered bit clock.

Output Register

The Output Register is clocked by RSCLK falling edges. RSCLK is the recovered bit clock divided-by-five and is synchronous to the received serial data.

Test Mode

Asserting PDT TEST input pin forces PDT into its test mode. This allows testing of the internal logic without the PLL clock multiplier. The internal clock source is replaced by the test clock provided at the FOTOFF input. An automatic test system can clock the PDT through functional test patterns at any rate, typically less than 25 MHz, or any sequence to facilitate logic verification.

In PDT test mode, LSCLK strobes data into the Input Register and provides initialization to the internal counter.

The PDR test mode allows testing of the internal logic without the PLL. When TEST is HIGH, the internal clock source is replaced by the test clock provided at the LRX/LRY inputs. (Note: The loopback data path in the Am79866 PDR cannot be tested in test mode.)

An automatic test system can clock the PDR through functional test patterns at any rate, typically less than 25 MHz, or any sequence to facilitate logic verification.

ABSOLUTE MAXIMUM RATINGS

Storage Temperature	-65°C to +150°C
Ambient Temperature under bias	-55°C to +125°C
Supply Voltage (Vcc) to Ground Potential Continuous	-0.5 V to +7.0 V
DC Voltage Applied to Outputs	-0.5 to Vcc Max.
DC Input Voltage	-0.5 V to +5.5 V
DC Output Current	±100 mA
DC Input Current	-30 to +5.0 mA

OPERATING RANGES**Commercial (C) Devices**

Ambient Temperature (T _A)	0°C to 70°C
Supply Voltage (Vcc)	+4.75 V to +5.25 V

T-75-49

Operating ranges define those limits between which the functionality of the device is guaranteed.

Stresses above those listed under Absolute Maximum Ratings may cause permanent device failure. Functionality at or above these limits is not implied. Exposure to absolute maximum ratings for extended periods may affect device reliability.

DC CHARACTERISTICS over operating range unless otherwise specified**Am79865 PDT**

Parameter Symbol	Parameter Description	Test Conditions	Min.	Typ. (Note 2)	Max.
TTL Inputs: T_{DATA} 4-0, LSCLK, FOTOFF, LPBCK, TEST					
V _{IH}	Input HIGH Voltage	Vcc = Max. (Note 3)	2.0 V		
V _{IL}	Input LOW Voltage	Vcc = Max. (Note 3)			0.8 V
V _I	Input Clamp Voltage	Vcc = Min., I _{IN} = -18 mA			-1.5 V
I _{IH}	Input HIGH Current	Vcc = Max., V _{IN} = 2.7 V			50 μA
I _{IL}	Input LOW Current	Vcc = Max., V _{IN} = 0.4 V			-400 μA
I _I	Input Leakage Current	Vcc = Max., V _{IN} = 5.5 V			50 μA
PECL Outputs: TX, TX; LTX, LTY					
V _{OH}	Output HIGH Voltage	PECL load (Note 4)	Vcc-1.025 V		Vcc-0.88 V
V _{OL}	Output LOW Voltage	PECL load (Note 4)	Vcc-1.81 V		Vcc-1.62 V
Power Supplies					
I _{CC1}	Vcc1 Supply Current	Vcc1 = Vcc2 = Max. (Note 5)		15 mA	
I _{CC2}	Vcc2 Supply Current	Vcc1 = Vcc2 = Max.		65 mA	

DC CHARACTERISTICS over operating range unless otherwise specified

Am79866 PDR

Parameter Symbol	Parameter Description	Test Conditions	Min.	Typ. (Note 2)	Max.
TTL Inputs: LSCLK, LPBCK, TEST					
V _{IH}	Input HIGH Voltage	V _{CC} = Max. (Note 3)	2.0 V		
V _{IL}	Input LOW Voltage	V _{CC} = Max. (Note 3)			0.8 V
V _I	Input Clamp Voltage	V _{CC} = Min., I _{IN} = -18 mA			-1.5 V
I _{IH}	Input HIGH Current	V _{CC} = Max., V _{IN} = 2.7 V			50 μ A
I _{IL}	Input LOW Current	V _{CC} = Max., V _{IN} = 0.4 V			-400 μ A
I _I	Input Leakage Current	V _{CC} = Max., V _{IN} = 5.5 V			50 μ A
TTL Outputs: RDATA 4-0, SDO, RSCLK					
V _{OH}	Output HIGH Voltage	V _{CC} = Min., I _{OH} = -1 mA	2.4 V		
V _{OL}	Output LOW Voltage	V _{CC} = Min., I _{OL} = 4 mA			0.45 V
I _{SC}	Output Short Circuit Current	V _{CC} = Max., (Note 6)	-15 mA		-85 mA
Differential PECL Inputs: RX,RY; LRX,LRY					
V _{IN}	Input Voltage (Absolute High or Low)	V _{CC} = Max., (Note 3)	2.5 V		V _{CC}
V _{diff}	Input Differential Voltage	V _{CC} = Max., (Note 3,7)	50 mV		1.1 V
I _{IH}	Input HIGH Current	V _{CC} = Max., V _{IN} = V _{CC} - 0.88 V			220 μ A
I _{IL}	Input LOW Current	V _{CC} = Max., V _{IN} = V _{CC} - 1.81 V	0.5 μ A		
Single-ended PECL Input: SDI					
V _{IHS}	Input Single-ended HIGH Voltage	V _{CC} = Max., (Note 3,8)	V _{CC} - 1.165 V		V _{CC} - 0.88 V
V _{ILS}	Input Single-ended LOW Voltage	V _{CC} = Max., (Note 3,8)	V _{CC} - 1.81 V		V _{CC} - 1.475 V
I _{IH}	Input HIGH Current	V _{CC} = Max., V _{IN} = V _{CC} - 0.88 V			220 μ A
I _{IL}	Input LOW Current	V _{CC} = Max., V _{IN} = V _{CC} - 1.81 V	0.5 μ A		
Power Supplies					
I _{CC1}	V _{CC1} Supply Current	V _{CC1} = V _{CC2} = Max.		15 mA	
I _{CC2}	V _{CC2} Supply Current	V _{CC1} = V _{CC2} = Max.		120 mA	

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SWITCHING CHARACTERISTICS over operating range unless otherwise specified**Am79865 PDT**

No.	Parameter Symbol	Parameter Description	Test Condition (Note 9)	Min.	Max.	Units
1	tp	LSCLK Period		40	40	ns
2	tpw	LSCLK Pulse Width HIGH		15		ns
3	tpw	LSCLK Pulse Width LOW		15		ns
4	ts	TDAT 4-0 to LSCLK Rise Setup Time		12		ns
5	th	TDAT 4-0 to LSCLK Rise Hold Time		3		ns
6	trf	TX,TY,LTX,LTY Rise Time	PECL load	0.3	3	ns
7	tf	TX,TY,LTX,LTY Fall Time	PECL load	0.3	3	ns
8	tskf	TX/TY, LTX/LTY Skew	PECL load		±200	ps

Am79866 PDR

21	f _{os}	LSCLK to received data frequency offset	(Note 10)		±0.25	%
22	tpw	LSCLK Pulse Width HIGH		15		ns
23	tpw	LSCLK Pulse Width LOW		16		ns
24	tpw	RSCLK Pulse Width HIGH	TTL load (Note 11)	10		ns
25	tpw	RSCLK Pulse Width LOW	TTL load (Note 11)	20		ns
26	tpd	RDAT 4-0 Valid to RSCLK Rise	TTL load (Note 12)	13		ns
27	tpd	RSCLK Rise to RDAT ₄₋₀ Invalid	TTL load (Note 12)	10		ns
28	ts	SDI to LSCLK Rise Setup Time		5		ns
29	th	SDI to LSCLK Rise Hold Time		7		ns
30	tpd	LSCLK Rise to SDO Delay	TTL load		30	ns

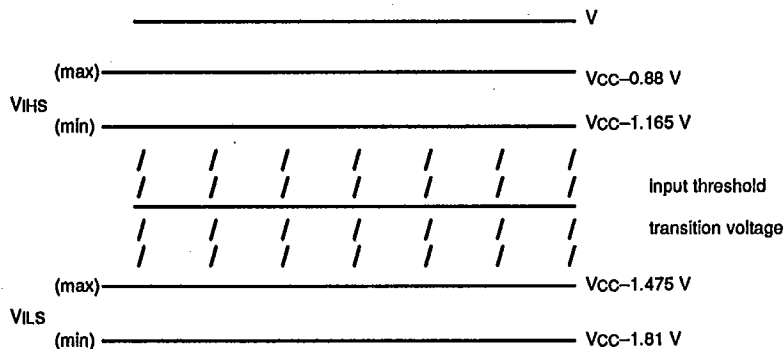
Notes:

t: not included in the production test.

- For conditions shown as Min. or Max, use the appropriate values specified under operating range.
- Typical limits are at V_{cc}=5.0 V, 25°C ambient and maximum loading.
- Typically measured with device in Test mode while monitoring output logic states.
- Tested for V_{cc}=Min, shown limits are specified over entire V_{cc} operating range.
- PDT I_{cc1} is tested with all PECL outputs terminated to V_{cc} (unloaded). The PECL outputs contribute 25 mA/pair nominally to I_{cc1} when they are loaded with PECL loads, 50 ohms to (V_{cc}-2). In calculating the chip power dissipation, the contribution by the output loads shall be multiplied by 1 V instead of by V_{cc}.
- Not more than one output should be shorted at a time. Duration of the short circuit test should not exceed one second.

Notes (Continued):

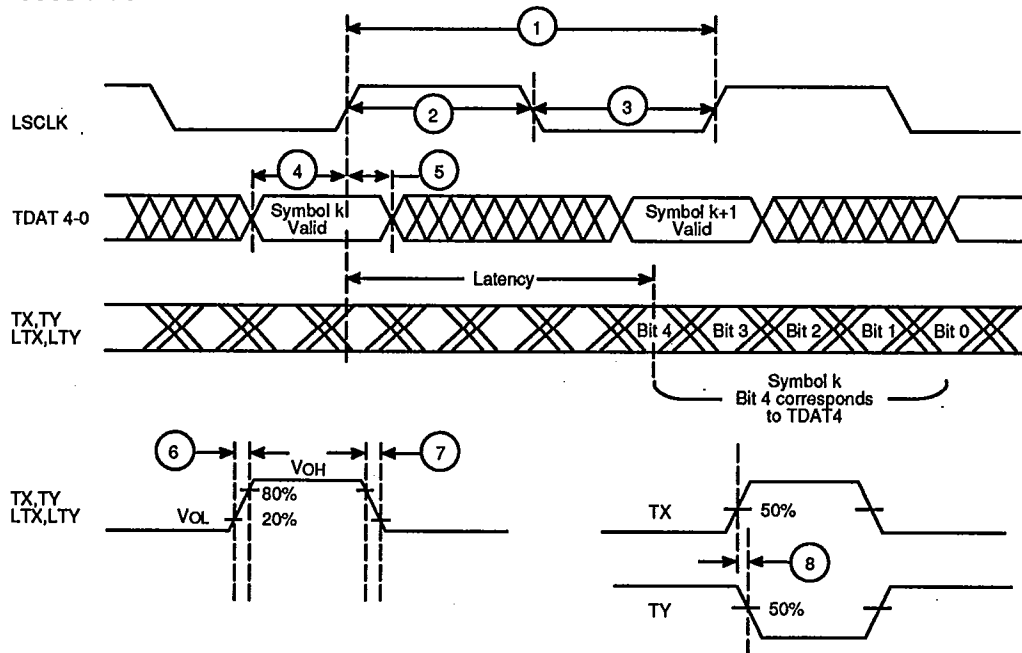
7. V_{dif} is tested with each input voltage within the V_{IN} range.
8. Device thresholds on the SDI pin are verified during production test by ensuring that the input threshold is less than V_{IHS} (min) and greater than V_{ILS} (max). The figure below shows the acceptable range (shaded area) for the transition voltage.



9. All timing references are made with respect to + 1.5 V for TTL-level signals or to the 50% point between V_{OH} and V_{OL} for PECL signals. PECL input rise and fall times must be $2\text{ ns} \pm 0.2\text{ ns}$ between 20 % and 80 % points. TTL input rise and fall times must be 2 ns between 1 V and 2 V.
10. Received data frequency is determined by serial data inputs. Multiply LSCLK frequency by 5 to convert the receive data bit rate.
11. Tested for 125 MBaud received data rate (1 bit-time is 8 ns). $tpw(\text{HIGH})$ is functionally 2 bit-time wide. $tpw(\text{LOW})$ is functionally 3 bit-time wide.
12. Tested for 125 MBaud received data rate (1 bit-time is 8 ns).

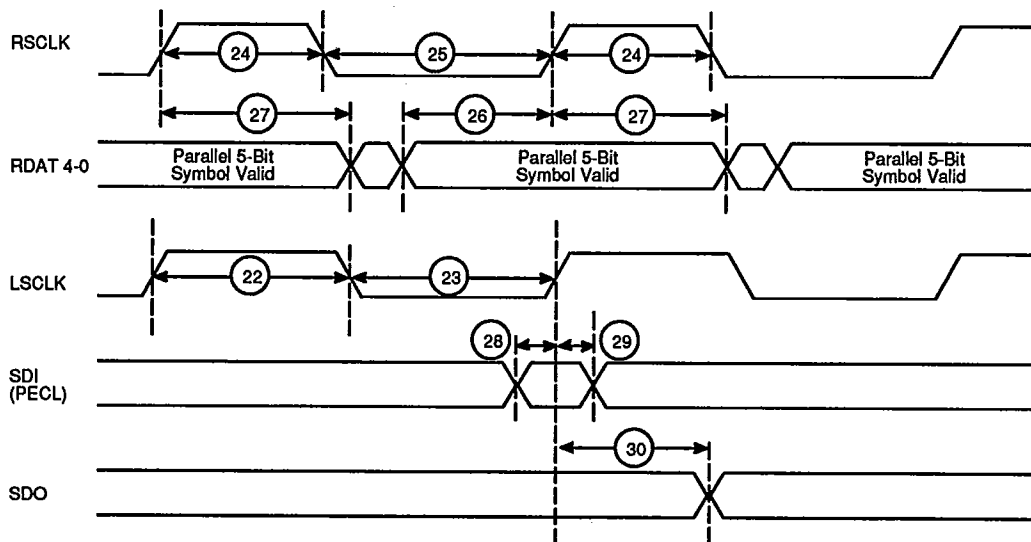
SWITCHING WAVEFORMS Am79865 PDT

T-75-49



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Am79866 PDR





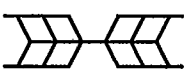


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KEY TO SWITCHING WAVEFORMS

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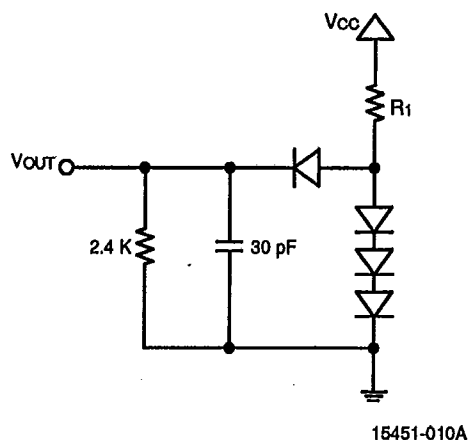
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WAVEFORM	INPUTS	OUTPUTS
	Must Be Steady	Will Be Steady
	May Change from H to L	Will Be Changing from H to L
	May Change from L to H	Will Be Changing from L to H
	Don't Care, Any Change Permitted	Changing, State Unknown
	Does Not Apply	Center Line Is High Impedance "Off" State

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SWITCHING TEST CIRCUITS

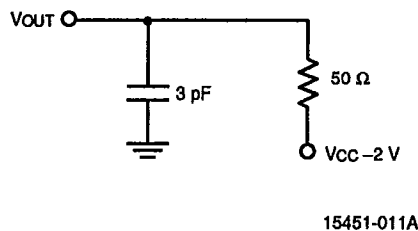
TTL Output Load



Notes:

1. $R_1 = 1\text{ K}\Omega$ for the $I_{OL} = 4\text{ mA}$
2. All diodes IN916 or IN3064, or equivalent.
3. $C_L = 30\text{ pF}$ includes scope probe, wiring and stray capacitances without device in test fixture.
4. AMD uses constant current (A.T.E.) load configurations and forcing functions. This figure is for reference only.

PECL Output Load



Notes:

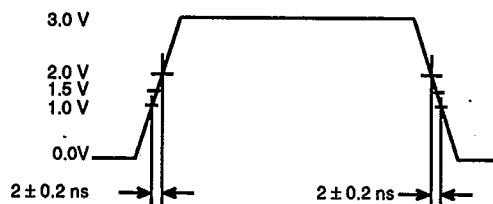
1. $C_L = 3\text{ pF}$ includes scope probe, wiring and stray capacitances without device in test fixture.
2. AMD uses Automatic test equipment (A.T.E.) load configurations and forcing functions. This figure is for reference only.

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SWITCHING TEST WAVEFORMS

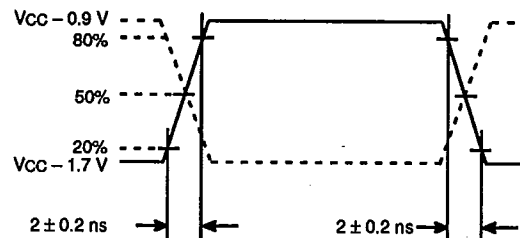
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TTL Input Waveform



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ECL Input Waveform



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